Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/847,037	MURREN ET AL.	
Examiner	Art Unit	
Linh LD Son	2135	

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Class	Subclass	Date	Examiner
726	26	12/26/2005	LLS
707	9	12/26/2005	LLS

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
-	<u></u>					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST SEARCH: USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	12/26/2005	LLS		